

**Notice of References Cited**

Application/Control No.

09/537,785

Applicant(s)/Patent Under  
Reexamination  
AONO ET AL.

Examiner

Saba Tsegaye

Art Unit

2662

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,515,967	02-2003	Wei et al.	370/244
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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